

Notice of References Cited	Application/Control No. 10/536,808	Applicant(s)/Patent Under Reexamination KIRSCH ET AL.	
	Examiner Shean C. Wu	Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0234384	12-2003	Heckmeier et al.	252/299.63
*	B	US-2004/0112275	06-2004	Heckmeier et al.	117/002
*	C	US-2005/0040365	02-2005	Heckmeier et al.	252/299.63
*	D	US-6,605,747	08-2003	Kondo et al.	568/642
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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